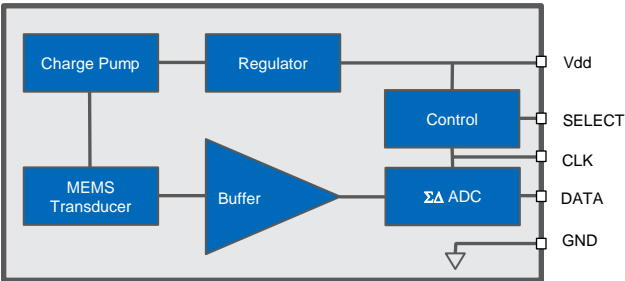


SPH8855LM4H-1
AEC-Q103-003 QUALIFIED DIGITAL BOTTOM PORT SISONIC™ MICROPHONE

The SPH8855LM4H-1 is a miniature, high-performance, low power, bottom port silicon digital microphone with a single bit PDM output. Using Syntiant's proven high performance SiSonic™ MEMS technology, the SPH8855LM4H-1 consists of an acoustic sensor, a low noise input buffer, and a sigma-delta modulator. This microphone is ideally suited for automotive applications, with Syntiant providing the industry's first AEC-Q103-003 qualified -26dBFS/Pa sensitivity digital microphone.

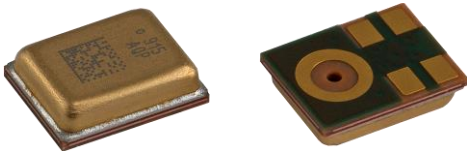


ABSOLUTE MAXIMUM RATINGS

Table 1: Absolute Maximum Ratings

Parameter	Absolute Maximum Rating	Units
Vdd to Ground	-0.5, +5.0	V
DATA, CLOCK, SELECT to Ground	-0.3, +5.0	V
Input Current	±5	mA
Short Circuit to/from DATA	Indefinite to Ground or Vdd	sec
Storage Temperature	-40 to +125	°C
Operating Temperature	-40 to +100	°C

Stresses exceeding these "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only. Functional operation at these or any other conditions beyond those indicated under "Acoustic & Electrical Specifications" is not implied. Exposure beyond those indicated under "Acoustic & Electrical Specifications" for extended periods may affect device reliability.



PRODUCT FEATURES

- AEC-Q103-003 Qualified
- Automotive applications required sensitivity(-26dBFS/Pa)
- Low Distortion / High AOP
- High SNR
- Low Current Consumption in Low-Power Mode
- Flat Frequency Response
- High Drive Capability
- RF Shielded
- Bottom Port
- Sensitivity Matching
- Supports Dual Multiplexed Channels
- Multiple Performance Modes (Sleep, Low-Power, Normal)
- Ultra-Stable Performance
- Omnidirectional
- Standard SMD Reflow
- LGA Package

TYPICAL APPLICATIONS

- Automotive

ACOUSTIC & ELECTRICAL SPECIFICATIONS¹

Table 2: General Microphone Specifications

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Tedge ≤ 3ns, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Supply Voltage	Vdd		1.65	1.8	3.6	V
Low Frequency Rolloff	LFRO	-3dB relative to 1 kHz	-	25	-	Hz
High Frequency Flatness		+3dB relative to 1 kHz	-	22	-	kHz
Resonant Frequency Peak	Fres	Free Field response	-	36	-	kHz
DC Offset		Fullscale = ±100	-3.25	-	0.1	% FS
Directivity			Omnidirectional			
Polarity		Increasing sound pressure	Increasing density of 1's			
Data Format			½ Cycle PDM			
Sensitivity Drop		Vdd(min) ≤ Vdd ≤ Vdd(max)	-	-	±0.25	dB
Clock Input Capacitance	Cin		-	15	-	pF
Data Output Capacitance	Cout		-	55	-	pF
Data Output Load	Cload		-	-	110	pF
SELECT (high)			Vdd-0.2	-	3.6	V
SELECT (low)			-0.3	-	0.2	V
Short Circuit Current	Isc	Grounded DATA pin	1	-	20	mA
Fall-asleep Time ^{3,4}		Fclock < 250kHz	-	-	10	ms
Wake-up Time ^{3,5}		Fclock ≥ 500kHz	-	-	35	ms
Startup Time ³		Powered Down → Active, S within 1 dB of final value	-	-	35	ms
Time to First Data Bit ⁶		Time from valid Vdd and CLK until the first logical bit is driven on the DATA line. The output is tristate until First Data Bit.	-	4	-	ms
Mode-Change Time ^{3, 6}		Low Power Mode ⇔ Normal Mode	-	-	17	ms

SPH8855LM4H-1

AEC-Q103-003 QUALIFIED DIGITAL BOTTOM PORT SISONIC™ MICROPHONE

Table 3: Normal Mode

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Fclock = 2.4 MHz (D.C. = 50%), Tedge ≤ 3ns, SELECT grounded, no load, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Supply Current ²	Idd	Fclock = 1.2 MHz	-	500	550	µA
		Fclock = 1.536 MHz	-	580	650	
		Fclock = 2.4 MHz	600	800	1000	
		Fclock = 3.072 MHz	-	975	1150	
		Fclock = 4.8 MHz	-	1425	1650	
Sensitivity	S	94 dB SPL @ 1 kHz	-27	-26	-25	dBFS
Signal to Noise Ratio	SNR	94 dB SPL @ 1 kHz, A-weighted, Fclock = 1.2 MHz	-	64.5	-	dB(A)
		94 dB SPL @ 1 kHz, A-weighted, Fclock = 1.536 MHz	-	66	-	
		94 dB SPL @ 1 kHz, A-weighted, Fclock = 2.4 MHz	-	66	-	
		94 dB SPL @ 1 kHz, A-weighted, Fclock = 3.072 MHz	-	66	-	
		94 dB SPL @ 1 kHz, A-weighted, Fclock = 4.8 MHz	-	66	-	
Near-Ultrasonic SNR		94 dB SPL, @ 19 kHz, BW = 18.5 - 20.0 kHz	-	78	-	dB
Total Harmonic Distortion	THD	94 dB SPL @ 1 kHz	-	0.05	-	%
		115 dB SPL @ 1 kHz	-	0.25	-	
		1% THD @ 1 kHz, S = typ	-	118	-	dB SPL
Acoustic Overload Point	AOP	10% THD @ 1 kHz, S = typ	-	121	-	dB SPL
Power Supply Rejection Ratio	PSRR	200 mVpp sinewave @ 1 kHz	-	74	-	dB V/FS
Power Supply Rejection	PSR+N	200 mVpp 7/8 duty cycle rectangular waveform @ 217 Hz, A-weighted	-	-87		dBFS(A)

Table 4: Low-Power Mode

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Fclock = 768 kHz (D.C. = 50%), Tedge ≤ 3ns, SELECT grounded, no load, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Supply Current ²	Idd		240	260	330	µA
Sensitivity	S	94 dB SPL @ 1 kHz	-27	-26	-25	dBFS
Signal to Noise Ratio	SNR	94 dB SPL @ 1 kHz, A-weighted (BW = 8 kHz)	-	64	-	dB(A)
Total Harmonic Distortion	THD	94 dB SPL @ 1 kHz	-	0.05	-	%
		1% THD @ 1 kHz, S = typ	-	118	-	dB SPL
Acoustic Overload Point	AOP	10% THD @ 1 kHz, S = typ	-	121	-	dB SPL
Power Supply Rejection Ratio	PSRR	200 mVpp sinewave @ 1 kHz		80	-	dBV/FS
Power Supply Rejection	PSR+N	200 mVpp 7/8 duty cycle rectangular waveform @ 217 Hz, A-weighted	-	-89	-	dBFS(A)

SPH8855LM4H-1

AEC-Q103-003 QUALIFIED DIGITAL BOTTOM PORT SISONIC™ MICROPHONE

Table 5: Sleep Mode

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Fclock = 0 Hz, SELECT grounded, no load, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Sleep Current	Isleep		-	40	55	µA

¹ Sensitivity and Supply Current are 100% tested.

² Idd varies with Cload according to: $\Delta I_{dd} = 0.5 \cdot V_{dd} \cdot \Delta C_{load} \cdot F_{clock}$.

³ Valid microphone states are: Powered Down Mode (mic off), Sleep Mode (low current, DATA = high-Z, fast startup), Low-Power Mode (low clock speed) and Normal Mode.

⁴ Time from Fclock < 250 kHz to Isleep specification is met when transitioning from Active Mode to Sleep Mode.

⁵ Time from Fclock ≥ 500 kHz to all applicable specifications are met when transitioning from Sleep Mode to Active Mode.

⁶ Audio is temporarily muted during the transition between any microphone state.

Table 6: Digital Interface

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Tedge ≤ 3ns, unless otherwise indicated

Parameter	Symbol	Conditions	Min	Typ	Max	Units
Logic Input High ⁷	Vih		0.65xVdd	-	3.6	V
Logic Input Low ⁷	Vil		-0.3	-	0.35xVdd	V
Logic Output High ⁷	Voh	I _{OUT} = 2 mA	Vdd-0.45	-	Vdd	V
Logic Output Low ⁷	Vol	I _{OUT} = 2 mA	0	-	0.45	V
Low→High Threshold ⁸	VI-h		-	-	0.65xVdd	V
High→Low Threshold ⁸	Vh-l		0.35xVdd	-	-	V
Hysteresis Width ⁸	Vhyst		0.05xVdd	-	0.20xVdd	V
Clock Frequency ⁷	Fclock	Sleep Mode	0	-	250	kHz
		Low-Power Mode	500	-	900	
		Normal Mode	1.1	-	4.8	MHz
Clock Duty Cycle	D.C.		40	50	60	%
Delay Time to Data Line Driven ⁷	Tdd		18	-	35	ns
Delay Time to Valid Data ⁷	Tdv	Max Cload	-	-	100	ns
Delay Time to High Z ⁷	Tdz		5	-	16	ns
Hold Time ⁷	Thold	Thold, as observed by the input device, will be dependent on Cload	5	-	-	ns

⁷ See Figure 1: Timing Diagram.

⁸ See Figure 2: Hysteresis Diagram.

Figure 1: Timing Diagram

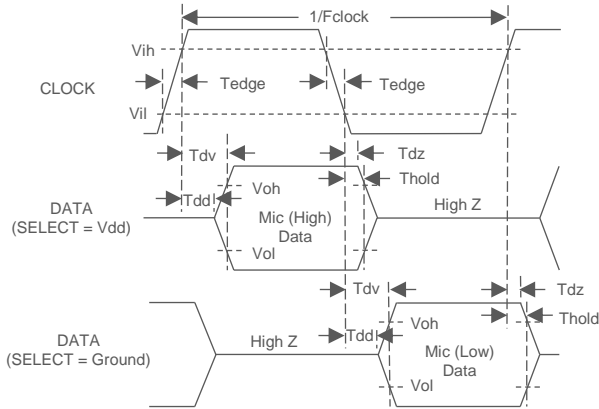


Figure 2: Hysteresis Diagram

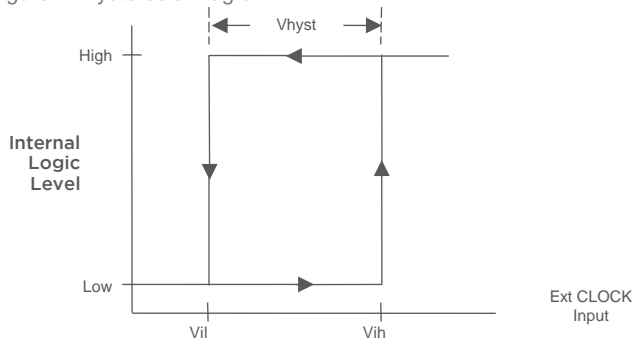


Figure 3: State Diagram

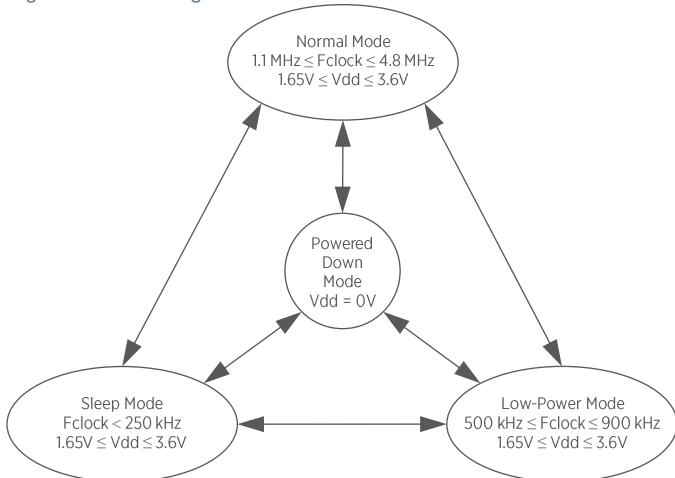


Figure 4: Typical Stereo Application Circuit

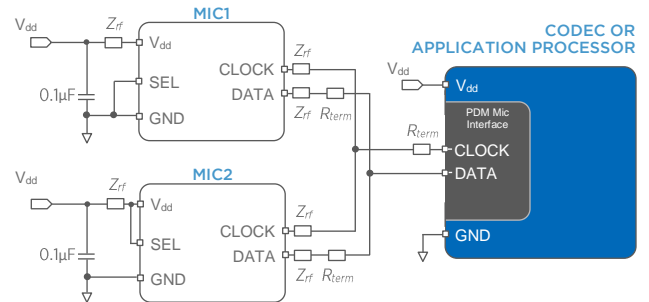
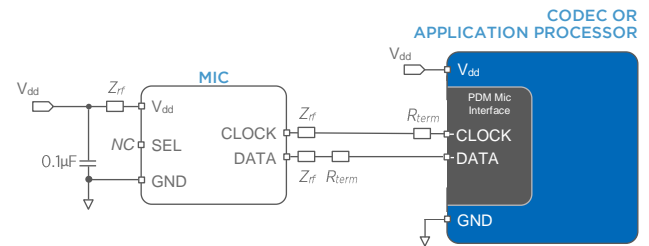


Figure 5: Typical Single-Microphone Application Circuit



NOTES:

All Ground pins must be connected to ground.
If necessary to improve RF performance, optional series components (resistors, ferrites, etc.) should be placed closest to the microphone pads.
Bypass capacitors should be placed near each Vdd pin for best performance.
Capacitors near the microphone should not contain Class 2 dielectrics due to their piezoelectric effect.

Table 7: SELECT Functionality

Microphone	SELECT	Asserts DATA on	Latch DATA on
Mic (High)	Vdd	CLK rising edge	CLK falling edge
Mic (Low)	Ground	CLK falling edge	CLK rising edge

PERFORMANCE CURVES

Test Conditions: 23 ±2°C, 55±20% R.H., Vdd=1.8 V, Fclock = 2.4 MHz, SELECT grounded, no load, unless otherwise indicated

Figure 6: Typical Free Field Magnitude and Masks

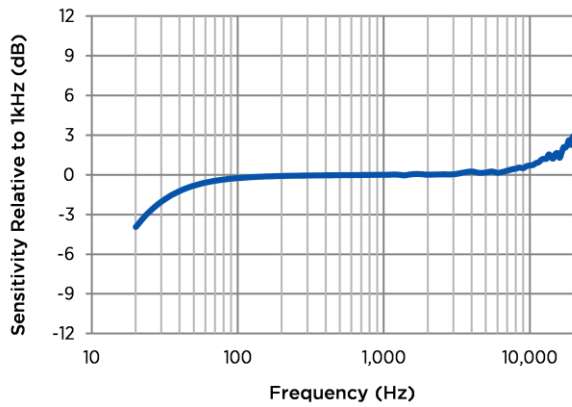


Figure 8: Typical Phase and Group Delay

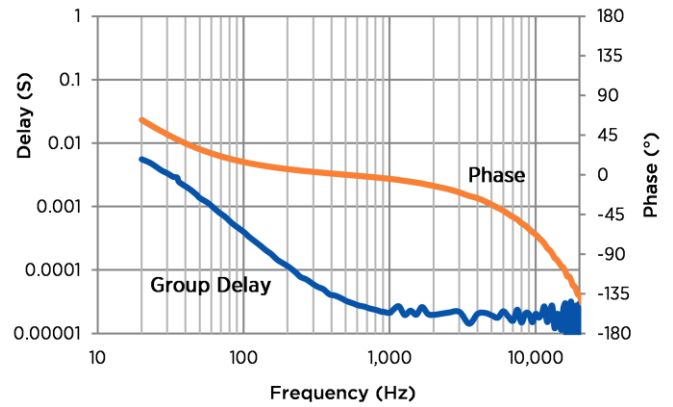


Figure 7: Typical THD vs SPL

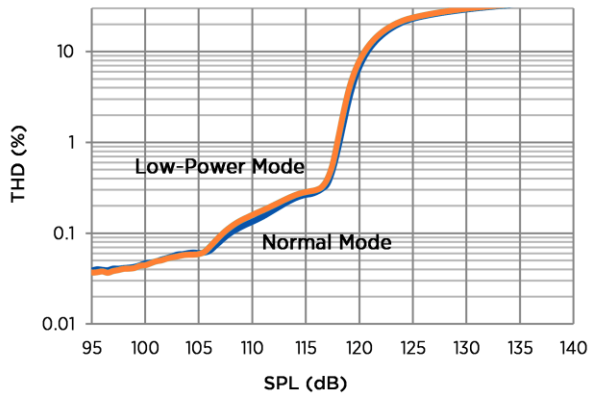
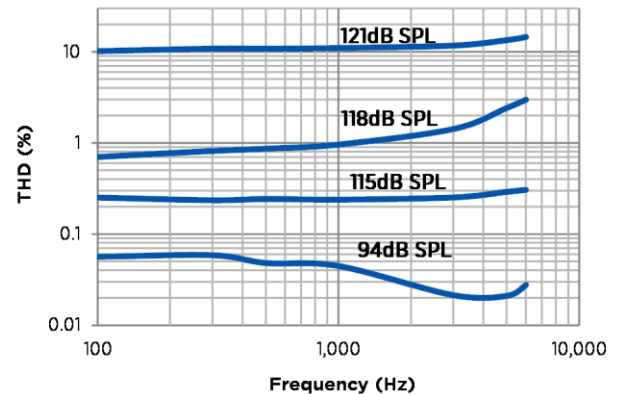


Figure 9: Typical THD vs Frequency



SPH8855LM4H-1

AEC-Q103-003 QUALIFIED DIGITAL BOTTOM PORT SISONIC™ MICROPHONE

Figure 10: Typical Free Field Ultrasonic Response

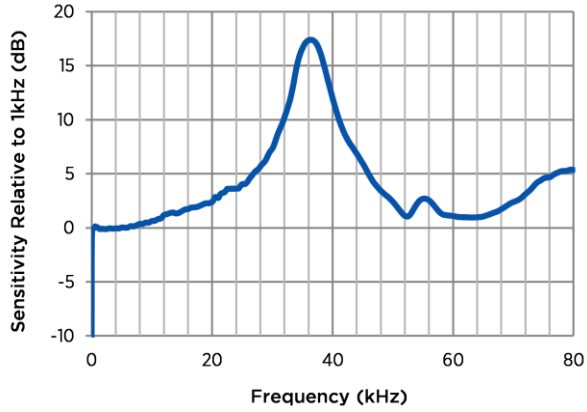


Figure 12: Noise Floor Power Spectral Density

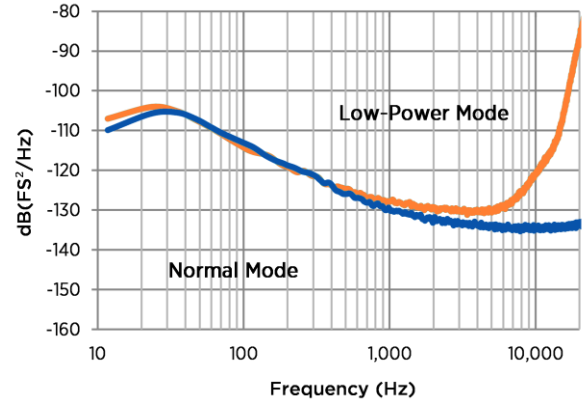


Figure 11: Typical Idd vs Vdd

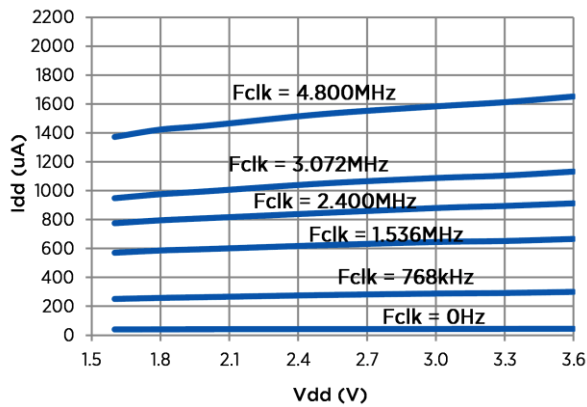
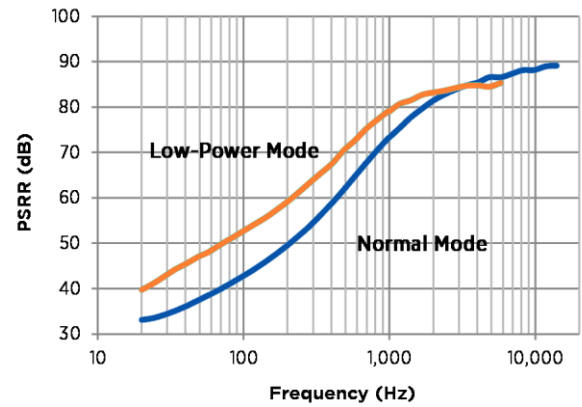
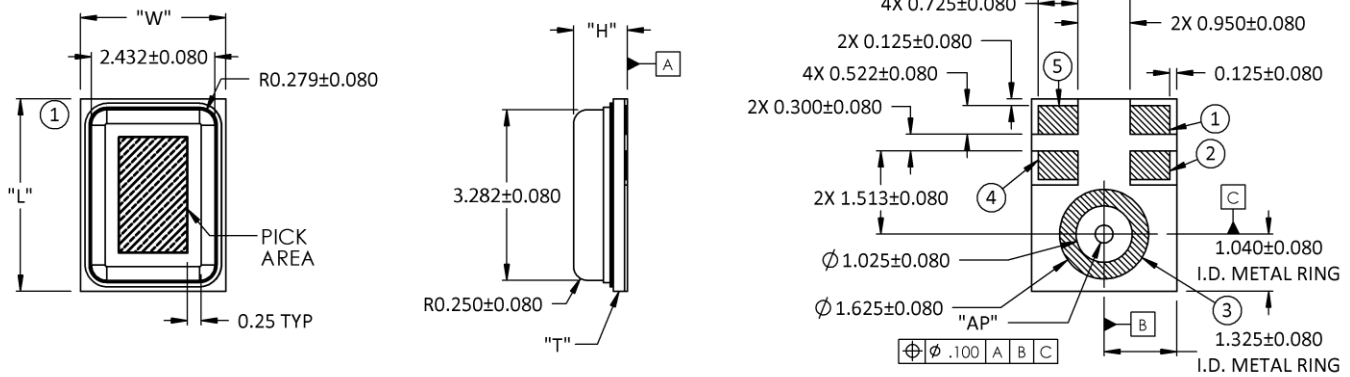
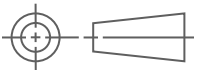
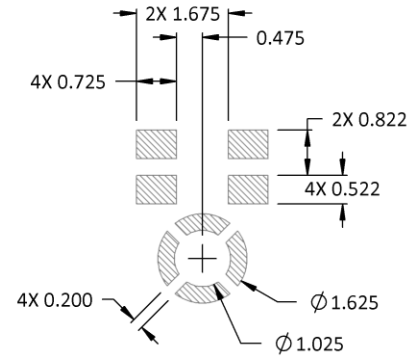
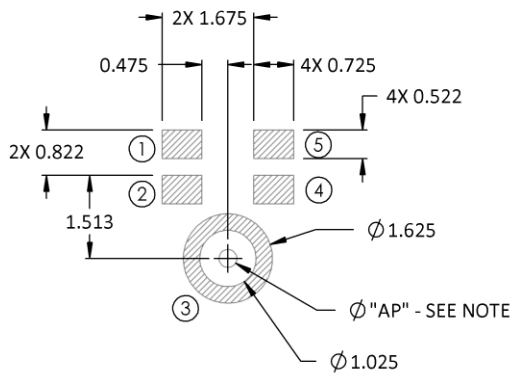


Figure 13: Typical PSRR

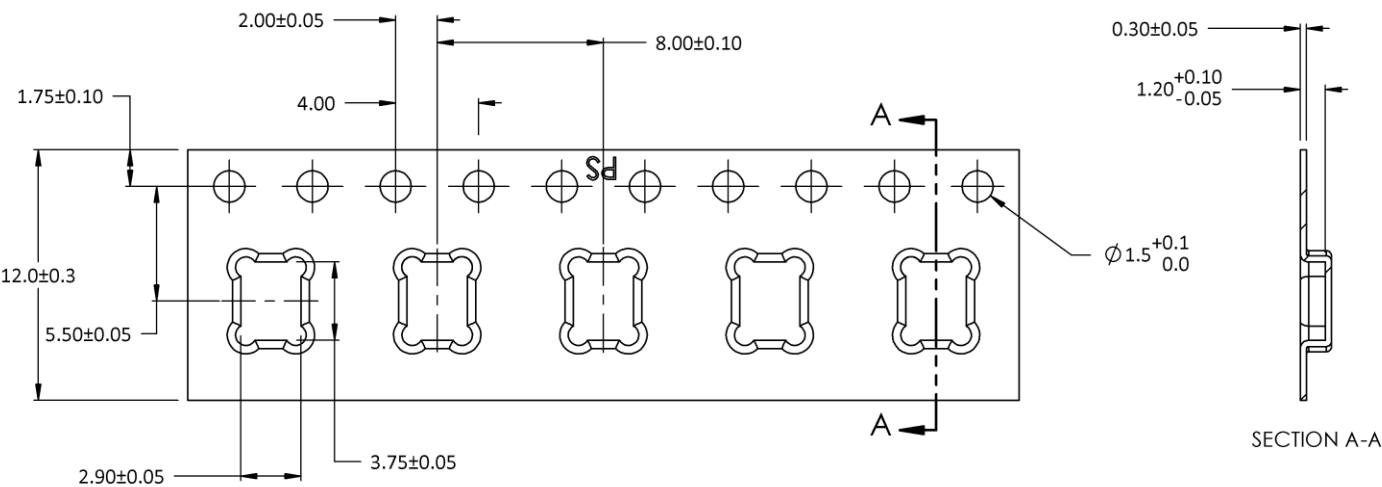




Item	Dimension	Tolerance	Pin #	Pin Name	Type	Description
Length (L)	3.5	±0.10	1	DATA	Digital O	PDM Output
Width (W)	2.65	±0.10	2	SELECT	Digital I	Lo/Hi (L/R) Select Connect to Vdd or GND
Height (H)	0.98	±0.10	3	GROUND	Power	Ground
Acoustic Port (AP)	Ø0.325	±0.05	4	CLOCK	Digital I	Clock Input
PCB Thickness (T)	0.307	±0.05	5	Vdd	Power	Power Supply

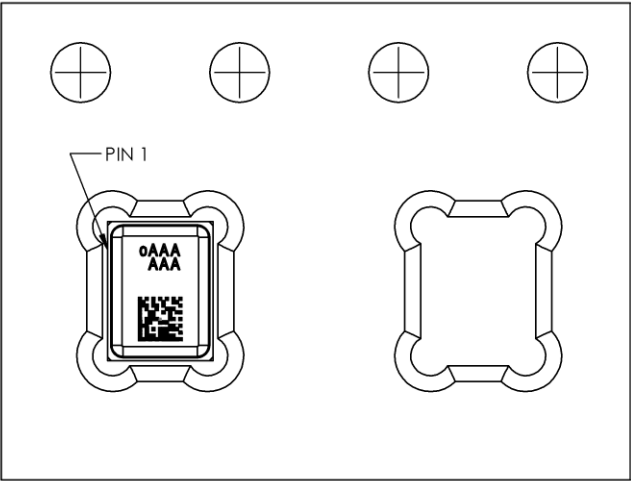


PACKAGING & MARKING DETAIL



Model Number	Suffix	Reel Diameter	Quantity Per Reel
SPH8855LM4H-1	-8	13"	5900

Component	Surface Resistance (ohms)
Reel	10 ⁵ - 10 ⁹
Carrier Tape	10 ⁵ - 10 ⁹
Cover Tape	10 ⁴ - 10 ¹⁰

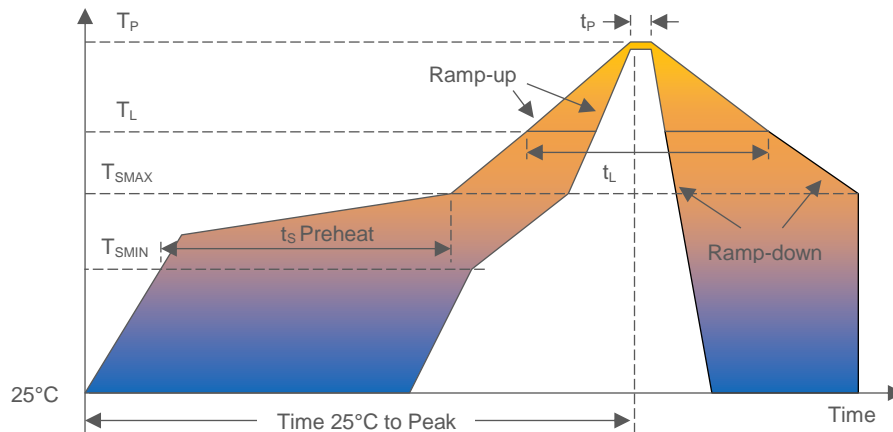


Letter: "o", orientation mark (pin 1)
AAAAAA = Internal Code
2D barcode "ABCDEFGHJKLMNPQRSTUVWXYZ0123456789":
Unique Job Identification Number for product traceability

NOTES:

Dimensions are in millimeters unless otherwise specified.
Vacuum pickup only in the pick area indicated in Mechanical Specifications.
Tape & reel per EIA-481.
Labels applied directly to reel and external package.
Shelf life: Twelve (12) months when devices are stored in the factory-supplied, unopened ESD moisture sensitive bag under the maximum environmental conditions of 30°C, 70% R.H.

RECOMMENDED REFLOW PROFILE



Profile Feature	Pb-Free
Average Ramp-up rate (T_{SMAX} to T_P)	3°C/second max.
Preheat <ul style="list-style-type: none"> Temperature Min (T_{SMIN}) Temperature Max (T_{SMAX}) Time (T_{SMIN} to T_{SMAX}) (t_s) 	150°C 200°C 60-180 seconds
Time maintained above: <ul style="list-style-type: none"> Temperature (T_L) Time (t_L) 	217°C 60-150 seconds
Peak Temperature (T_P)	260°C
Time within 5°C of actual Peak Temperature (t_P)	20-40 seconds
Ramp-down rate (T_P to T_{SMAX})	6°C/second max
Time 25°C to Peak Temperature	8 minutes max

NOTES:

Based on IPC/JEDEC J-STD-020 Revision C.

All temperatures refer to topside of the package, measured on the package body surface.

The actual reflow profile used should be optimized based on the reflow requirements of all components, board design, solder paste formulation and reflow equipment used. Details of recommended handling and manufacturing processes can be found in AN25 SMT Manufacturing Guidelines for SiSonic™ Microphones.

ADDITIONAL NOTES

- MSL (moisture sensitivity level) Class 1.
- Maximum of 3 reflow cycles is recommended.
- In order to minimize device damage:
 - Do not board wash or clean after the reflow process.
 - Do not brush board with or without solvents after the reflow process.
 - Do not directly expose to ultrasonic processing, welding, or cleaning.
 - Do not insert any object in port hole of device at any time.
 - Do not apply over 30 psi of air pressure into the port hole.
 - Do not pull a vacuum over port hole of the microphone.
 - Do not apply a vacuum when repacking into sealed bags at a rate faster than 0.5 atm/sec.
 - Do not directly expose to vapor phase soldering.

MATERIALS STATEMENT

Meets the requirements of the European RoHS directive 2011/65/EC as amended.

Meets the requirements of the industry standard IEC 61249-2-21:2003 for halogenated substances and Syntiant Green Materials Standards Policy section on Halogen-Free.

Product is Beryllium Free according to limits specified on the Syntiant Hazardous Material List (HSL for Products).

Ozone depleting substances are not used in the product or the processes used to make the product, including compounds listed in Annex A, B, and C of the "Montreal Protocol on Substances That Deplete the Ozone Layer."

RELIABILITY SPECIFICATIONS

Test	Description
Temperature Cycling	500 cycles of thermal shock from -55°C to +125°C with 15 minute soaks (JESD22-A104)
High Temperature Storage Life	+150°C environment for 500 hours (JESD22-A103)
High Temperature Operating Life	+105°C environmental while under bias for 1,000 hours (JESD22-A108)
Low Temperature Storage	-40°C environment for 1,000 hours (JESD22-A119)
Low Temperature Bias	-40°C environment while under bias for 1,000 hours (JESD22-A108)
Temperature/Humidity Storage	+85°C/85% R.H. environment unbiased for 1,000 hours (JESD22-A101A-B)
Temperature/Humidity Bias	+85°C/85% R.H. environment while under bias for 1,000 hours (JESD22-A101A-B)
Temperature/Humidity Cycle 1)	5 cycles (1 cycle = 24 hours). Read point after each cycle.
Temperature/Humidity Cycle 2)	Biased portion of the cycle: 65°C/90%RH, 10 hours at temperature/humidity.
Temperature/Humidity Cycle 3)	Unbiased portion of the cycle: 2 hours ramp down to -10°C/uncontrolled RH, 1 hour at temperature. 2 hours ramp up to 25°C/uncontrolled RH, 1 hour at temperature. (JESD22-A108/IEC 60068-2-2)
Early Life Failure Rate	+105°C environment while under bias for 24 hours (AEC Q100-008)
Variable Frequency Vibration	12 minutes in each X, Y, Z axis from 20 to 2,000 Hz with peak acceleration of 20g (JESD22-B103)
ESD-HBM	3 discharges at ±500V, ±1kV, ±1.5kV and ±2kV direct contact to I/O pins (AEC Q100-002)
ESD-CDM	3 discharges at ±500V and ±750V (AEC Q100-011)
Reflow	5x reflow cycles with peak temperature of +260°C (JEDEC 22-A113F)
Mechanical Shock	3 pulses of 10,000g in each of the X, Y, and Z directions (IEC 68-2-27)
Drop Test	Drop device 10X on each of 6 axes (60 drops total) from a height of 1.2m onto a concrete surface (QRP3032)

NOTES:

Microphones meet all acoustic and electrical specifications before and after reliability testing, except sensitivity which can deviate up to 3dB.

After 3 reflow cycles, the sensitivity of the microphones shall not deviate more than 1 dB from its initial value.

Temperature Storage testing is covered by Temperature Bias testing as Ta = Tj for Syntiant Microphones.

SPECIFICATION REVISIONS

Revision	Specification Changes	Date
A	MP Release (ECR-23-5443)	2/25/23
B	Correct AECQ format and storage temperature (ECR-24-6193)	5/31/24
C	Updated high temperature operating life test description in reliability specifications (ECR-24-6258)	7/23/24
C-1	Updated template	11/29/24

Information contained herein is subject to change without notice. It may be used by a party at their own discretion and risk. We do not guarantee any results or assume any liability in connection with its use. This publication is not to be taken as a license to operate under any existing patents.